

FDP6690S/FDB6690S

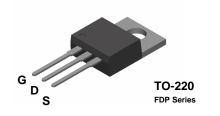
30V N-Channel PowerTrench^O SyncFET[™]

General Description

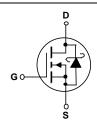
This MOSFET is designed to replace a single MOSFET and parallel Schottky diode in synchronous DC:DC power supplies. This 30V MOSFET is designed to maximize power conversion efficiency, providing a low $R_{\rm DS(ON)}$ and low gate charge. The FDP6690S includes an integrated Schottky diode using Fairchild's monolithic SyncFET technology. The performance of the FDP6690S/FDB6690S as the low-side switch in a synchronous rectifier is indistinguishable from the performance of the FDP6035AL/FDB6035AL in parallel with a Schottky diode.

Features

- 21 A, 30 V. $R_{DS(ON)} = 15.5 \ m\Omega \ @ \ V_{GS} = 10 \ V$ $R_{DS(ON)} = 23.0 \ m\Omega \ @ \ V_{GS} = 4.5 \ V$
- Includes SyncFET Schottky body diode
- Low gate charge (11nC typical)
- High performance trench technology for extremely low R_{DS(ON)} and fast switching
- High power and current handling capability







FDB Series

TO-263AB

Absolute Maximum Ratings T_A=25°C unless otherwise noted

Symbol	Parameter		Ratings	Units
V _{DSS}	Drain-Source Voltage		30	V
V _{GSS}	Gate-Source Voltage		±20	V
I _D	Drain Current - Continuous	(Note 1)	42	A
	- Pulsed	(Note 1)	140	
P _D	Total Power Dissipation @ T _C = 25°C		48	W
	Dera	ate above 25°C	0.5	W/°C
T _J , T _{STG}	Operating and Storage Junction Temperature Range		-55 to +150	°C
T _L	Maximum lead temperature for soldering purposes, 1/8" from case for 5 seconds		275	°C

Thermal Characteristics

$R_{\theta JC}$	Thermal Resistance, Junction-to-Case	2.6	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient	62.5	°C/W

Package Marking and Ordering Information

Device Marking	Device	Reel Size	Tape width	Quantity
FDB6690S	FDB6690S	13"	24mm	800 units
FDP6690S	FDP6690S	Tube	n/a	45

Symbol	Parameter	Test Conditions	Min	Тур	Max	Units
Drain-Sc	Durce Avalanche Ratings (Note	. 2)				
W _{DSS}	Drain-Source Avalanche Energy	Single Pulse, V _{DD} = 25 V, I _D =11A			140	mJ
I _{AR}	Drain-Source Avalanche Current				11	Α
Off Char	acteristics		1	<u>I</u>	I	I
BV _{DSS}	Drain-Source Breakdown Voltage	$V_{GS} = 0 \text{ V}, \qquad I_D = 1\text{mA}$	30			V
ΔBV _{DSS} ΔT _J	Breakdown Voltage Temperature Coefficient	I _D = 10mA, Referenced to 25°C		25		mV/°C
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} = 24 V, V _{GS} = 0 V			500	μA
I _{GSSF}	Gate-Body Leakage, Forward	V _{GS} = 20 V, V _{DS} = 0 V			100	nA
I _{GSSR}	Gate-Body Leakage, Reverse	$V_{GS} = -20 \text{ V}, V_{DS} = 0 \text{ V}$			-100	nA
On Char	acteristics (Note 2)		•	•		
V _{GS(th)}	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_D = 1mA$	1	2.2	3	V
$\Delta V_{GS(th)} \over \Delta T_J$	Gate Threshold Voltage Temperature Coefficient	I _D = 10mA, Referenced to 25°C		-4		mV/°C
R _{DS(on)}	Static Drain–Source On–Resistance	$V_{GS} = 10 \text{ V}, I_D = 21 \text{ A}$ $V_{GS} = 4.5 \text{ V}, I_D = 17 \text{ A}$ $V_{GS} = 10 \text{ V}, I_D = 21 \text{ A}, T_J = 125^{\circ}\text{C}$		12.0 18.5 18.0	15.5 23.0 22.5	mΩ
I _{D(on)}	On-State Drain Current	V _{GS} = 10 V, V _{DS} = 10 V	60			Α
g _{FS}	Forward Transconductance	$V_{DS} = 10 \text{ V}, I_{D} = 23 \text{ A}$		33		S
Dvnamio	Characteristics			l .		
C _{iss}	Input Capacitance	V _{DS} = 15 V, V _{GS} = 0 V,		1238		pF
Coss	Output Capacitance	f = 1.0 MHz		342		pF
C _{rss}	Reverse Transfer Capacitance			104		pF
Switchin	ng Characteristics (Note 2)			I		
t _{d(on)}	Turn-On Delay Time	$V_{DS} = 15 \text{ V}, I_{D} = 1 \text{ A},$		11	20	ns
t _r	Turn-On Rise Time	$V_{GS} = 10 \text{ V}, \qquad R_{GEN} = 6 \Omega$		9	18	ns
t _{d(off)}	Turn-Off Delay Time			23	37	ns
t _f	Turn-Off Fall Time			13	23	ns
Qq	Total Gate Charge	V _{DS} = 15 V, I _D = 21A,		11	15	nC
Q _{qs}	Gate-Source Charge	V _{GS} = 5 V		5		nC
Q_{gd}	Gate-Drain Charge			4		nC
Drain_S	ource Diode Characteristics			I		
V _{SD}	Drain–Source Diode Forward Voltage	$V_{GS} = 0 \text{ V}, I_S = 3.5 \text{ A} \text{(Note 1)}$ $V_{GS} = 0 \text{ V}, I_S = 7 \text{ A} \text{(Note 1)}$		0.51 0.69	0.7	V
t _{rr}	Diode Reverse Recovery Time	$I_F = 3.5 \text{ A},$		21		nS
Q _{rr}	Diode Reverse Recovery Charge	$d_{iF}/d_t = 300 \text{ A/}\mu\text{s}$ (Note 2)		25	1	nC

Notes:

- $\begin{tabular}{ll} \textbf{1. Pulse Test: Pulse Width < } 300\mu s, Duty Cycle < 2.0\% \\ \textbf{2. See "SyncFET Schottky body diode characteristics" below. } \end{tabular}$

Typical Characteristics

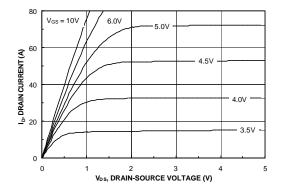


Figure 1. On-Region Characteristics.

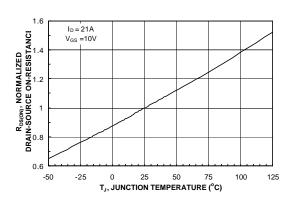


Figure 3. On-Resistance Variation with Temperature.

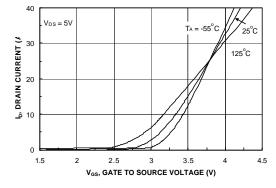


Figure 5. Transfer Characteristics.

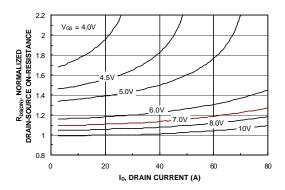


Figure 2. On-Resistance Variation with Drain Current and Gate Voltage.

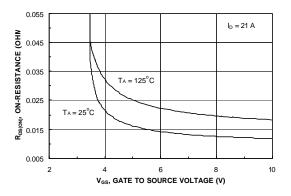


Figure 4. On-Resistance Variation with Gate-to-Source Voltage.

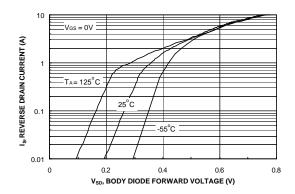
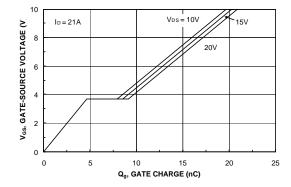


Figure 6. Body Diode Forward Voltage Variation with Source Current and Temperature.

Typical Characteristics (continued)



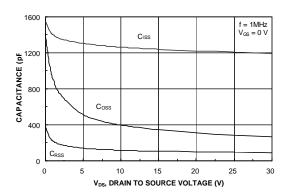
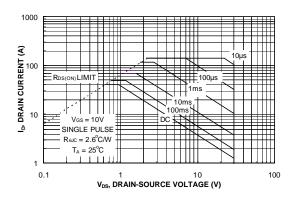


Figure 7. Gate Charge Characteristics.





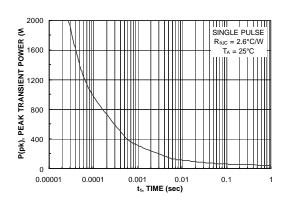


Figure 9. Maximum Safe Operating Area.

Figure 10. Single Pulse Maximum Power Dissipation.

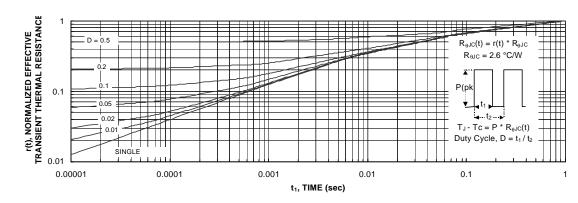


Figure 11. Transient Thermal Response Curve.

Typical Characteristics (continued)

SyncFET Schottky Body Diode Characteristics

Fairchild's SyncFET process embeds a Schottky diode in parallel with PowerTrench MOSFET. This diode exhibits similar characteristics to a discrete external Schottky diode in parallel with a MOSFET. Figure 12 FDP6690S.

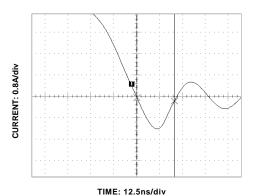


Figure 12. FDP6690S SyncFET body diode reverse recovery characteristic.

For comparison purposes, Figure 13 shows the reverse recovery characteristics of the body diode of an equivalent size MOSFET produced without SyncFET (FDP6035AL).

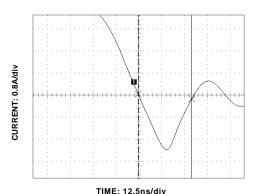


Figure 13. Non-SyncFET (FDP6035AL) body diode reverse recovery characteristic.

Schottky barrier diodes exhibit significant leakage at high temperature and high reverse voltage. This will increase the power in the device.

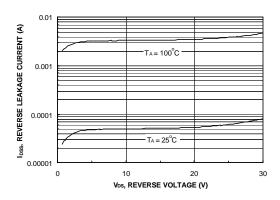


Figure 14. SyncFET diode reverse leakage versus drain-source voltage and temperature.

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Rev. H4